

# **Dual P-Channel 100 V (D-S) MOSFET**

PRODUCT SUMMARY				
V <sub>DS</sub> (V)	-100			
$R_{DS(on)}$ max. ( $\Omega$ ) at $V_{GS}$ = -10 V	0.110			
$R_{DS(on)}$ max. ( $\Omega$ ) at $V_{GS}$ = -4.5 V	0.155			
Q <sub>g</sub> typ. (nC)	5.65			
I <sub>D</sub> (A)	-4.5			
Configuration	Single			

## 

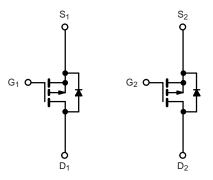
#### **FEATURES**

- TrenchFET® power MOSFET
- 100 % R<sub>g</sub> and UIS tested



#### **APPLICATIONS**

- Active clamp in intermediate DC/DC power supplies
- LED Lighting
- Load switch



P-Channel MOSFET

P-Channel MOSFET

<b>ABSOLUTE MAXIMUM RATING</b>	<b>iS</b> (T <sub>A</sub> = 25 °C, u	inless other	wise noted)	
PARAMETER		SYMBOL	LIMIT	UNIT
Drain-source voltage		$V_{DS}$	-100	V
Gate-source voltage		$V_{GS}$	± 20	v
Continuous drain current (T <sub>J</sub> = 150 °C)	T <sub>C</sub> = 25 °C		-4.5	
	T <sub>C</sub> = 70 °C	1 .	-3.6	
	T <sub>A</sub> = 25 °C	I <sub>D</sub>	-2.8 b, c	
	T <sub>A</sub> = 70 °C		-2.1 <sup>b, c</sup>	^
Pulsed drain current (t = 100 µs)		I <sub>DM</sub>	-20	- A
Continuous source-drain diode current	T <sub>C</sub> = 25 °C		-4.5 <sup>a</sup>	
	T <sub>A</sub> = 25 °C	l <sub>S</sub>	-2.8 <sup>b, c</sup>	
Single pulse avalanche current	L = 0.1 mH	I <sub>AS</sub>	-15	
Single pulse avalanche energy	L = U.1 MIH	E <sub>AS</sub>	11.25	mJ
Maximum power dissipation	T <sub>C</sub> = 25 °C		27.8	
	T <sub>C</sub> = 70 °C		17.8	T w
	T <sub>A</sub> = 25 °C	$P_D$	3.5 <sup>b, c</sup>	- vv
	T <sub>A</sub> = 70 °C		2.2 <sup>b, c</sup>	T
Operating junction and storage temperature range		T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C
Soldering recommendations (peak temperature) d, e			260	

THERMAL RESISTANCE RATINGS						
PARAMETER		SYMBOL	TYPICAL	MAXIMUM	UNIT	
Maximum junction-to-ambient b, f	t ≤ 10 s	R <sub>thJA</sub>	29	36	°C/W	
Maximum junction-to-case (drain)	Steady state	R <sub>thJC</sub>	3.6	4.6	G/ <b>VV</b>	

服务热线:400-655-8788

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<b>SPECIFICATIONS</b> (T <sub>J</sub> = 25 °C, unless otherwise noted)								
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT		
Static								
Drain-source breakdown voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	-100	-	-	V		
V <sub>DS</sub> temperature coefficient	$\Delta V_{DS}/T_{J}$	1 250	-	-63	-	m\//°C		
V <sub>GS(th)</sub> temperature coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = -250 μA	-	4.2	-	mV/°C		
Gate-source threshold voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	-1.1	-	-2.6	V		
Gate-source leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$	-	-	± 100	nA		
Zero gate voltage drain current	1	$V_{DS} = -100 \text{ V}, V_{GS} = 0 \text{ V}$	-	-	-1	μА		
	I <sub>DSS</sub>	$V_{DS} = -100 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 70 ^{\circ}\text{C}$	-	-	-10			
On-state drain current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge -10 \text{ V}, V_{GS} = -10 \text{ V}$	-15	-	-	Α		
Duning and supplied and a second supplied an	D	$V_{GS} = -10 \text{ V}, I_D = -3.8 \text{ A}$	-	0.110	0.132	Ω		
Drain-source on-state resistance a	R <sub>DS(on)</sub>	$V_{GS} = -4.5 \text{ V}, I_D = -3.2 \text{ A}$	-	0.155	0.186	52		
Forward transconductance <sup>a</sup>	9fs	$V_{DS} = -10 \text{ V}, I_{D} = -3.8 \text{ A}$	=	8	-	S		
Dynamic <sup>b</sup>								
Input capacitance	C <sub>iss</sub>		-	515	-	pF		
Output capacitance	C <sub>oss</sub>	$V_{DS} = -50 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	-	162	-			
Reverse transfer capacitance	C <sub>rss</sub>		-	10	-			
Total gate charge	$Q_g$ $V_{DS} = -50 \text{ V}, V_{GS} = -10 \text{ V}$	$V_{DS} = -50 \text{ V}, V_{GS} = -10 \text{ V}, I_{D} = -3.8 \text{ A}$	-	10.9	16.5	nC		
Total gate charge			-	5.65	8.5			
Gate-source charge	Q <sub>gs</sub>	$V_{DS} = -50 \text{ V}, V_{GS} = -4.5 \text{ V}, I_D = -3.8 \text{ A}$	-	1.7	-			
Gate-drain charge	$Q_{gd}$		-	2.5	-			
Gate resistance	R <sub>g</sub>	f = 1 MHz	1.96	9.8	19.6	Ω		
Turn-on delay time	t <sub>d(on)</sub>		-	10	20			
Rise time	t <sub>r</sub>	$V_{DD}$ = -50 V, $R_L$ = 16.1 $\Omega$ , $I_D$ $\cong$ -3.1 A,	-	22	40			
Turn-off delay time	t <sub>d(off)</sub>	$V_{GEN} = -10 \text{ V}, R_g = 1 \Omega$	-	20	40			
Fall time	t <sub>f</sub>		-	20	40	ns		
Turn-on delay time	t <sub>d(on)</sub>		-	35	55	115		
Rise time	t <sub>r</sub>	$V_{DD}$ = -50 V, $R_L$ = 16.1 $\Omega$ , $I_D \cong$ -3.1 A,	-	40	60	- - -		
Turn-off delay time	t <sub>d(off)</sub>	$V_{GEN}$ = -4.5 V, $R_g$ = 1 $\Omega$	-	22	40			
Fall time	t <sub>f</sub>		-	1622	40			
<b>Drain-Source Body Diode Characterist</b>	ics							
Continuous source-drain diode current	Is	T <sub>C</sub> = 25 °C	-	-	-16	Δ		
Pulse diode forward current	I <sub>SM</sub>	-		-	-15	A		
Body diode voltage	V <sub>SD</sub>	I <sub>S</sub> = -3.1 A, V <sub>GS</sub> = 0 V	-	-0.8	-1.2	V		
Body diode reverse recovery time	t <sub>rr</sub>	0.1.0.4.1.1.1.1.1.1.1.1.1.1.1.1.1.1.1.1.	-	43	65	ns		
Body diode reverse recovery charge	Q <sub>rr</sub>		-	80	120	nC		
Reverse recovery fall time	ta	$I_F = -3.1 \text{ A, di/dt} = 100 \text{ A/}\mu\text{s, T}_J = 25 ^{\circ}\text{C}$	=	36	-	ns		
Reverse recovery rise time	t <sub>b</sub>	]	-	7	-			

#### Notes

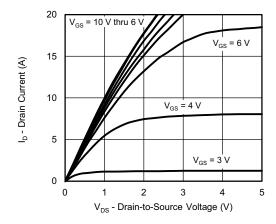
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- a. Pulse test; pulse width  $\leq 300~\mu s,~duty~cycle \leq 2~\%$
- b. Guaranteed by design, not subject to production testing

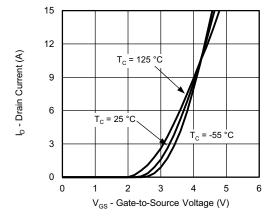
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



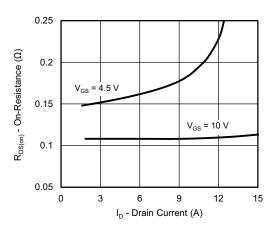
## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



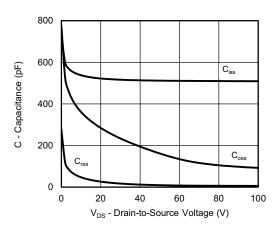
**Output Characteristics** 



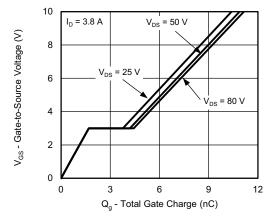
**Transfer Characteristics** 



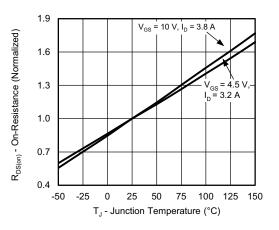
On-Resistance vs. Drain Current and Gate Voltage



Capacitance



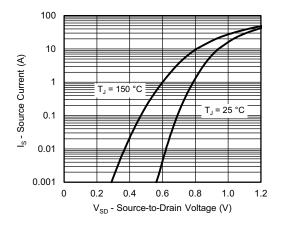
**Gate Charge** 



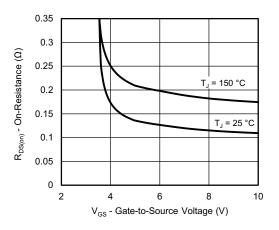
On-Resistance vs. Junction Temperature



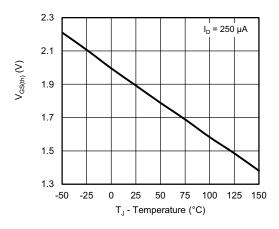
## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



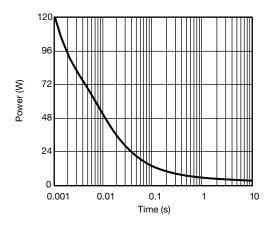
Source-Drain Diode Forward Voltage



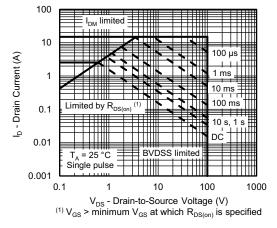
On-Resistance vs. Gate-to-Source Voltage



**Threshold Voltage** 



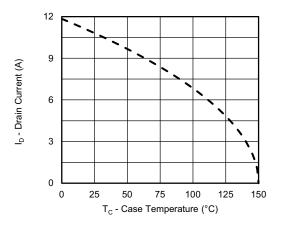
Single Pulse Power, Junction-to-Ambient



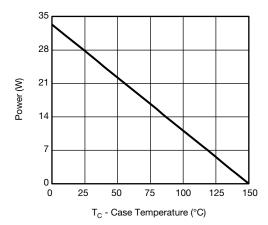
Safe Operating Area, Junction-to-Ambient



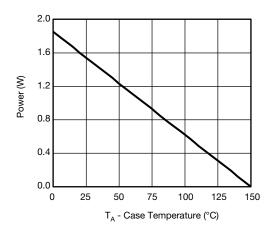
## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



#### Current Derating a







Power, Junction-to-Ambient

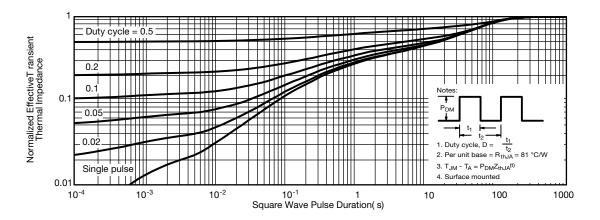
### Note

a. The power dissipation P<sub>D</sub> is based on T<sub>J</sub> max. = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

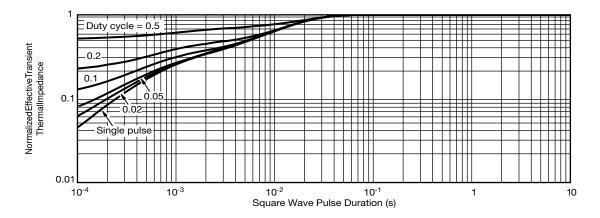
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## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case



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